

<b>Notice of References Cited</b>		Application/Control No. 10/563,148	Applicant(s)/Patent Under Reexamination TANAKA, YORIO	
		Examiner HAMID R. BADR	Art Unit 1794	Page 1 of 1

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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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